QM-Anlage **Technical Information for our Customers**

4.3-05 Vers. A Application Areas and Compatibilities of our Photoresists, Developers and Removers

Vers. A 01/2018 With the information collected in this document, we would like to give you an initial overview of the basic areas of application and compatibility of our Seite 1/2 photo chemicals. We would be happy to advise you in more detail personally!

Photoresists: Application Areas and Compatibilities

	Recommended Applications ¹	Resist Family	Photoresists	Resist Film Thickness ²	Recommended Developers ³	Recommended Removers	
Positive	Improved adhesion for wet etching, no focus on steep resist sidewalls	AZ [®] 1500	AZ [®] 1505 AZ [®] 1512 HS AZ [®] 1514 H AZ [®] 1518	≈ 0.5 μm ≈ 1.0 - 1.5 μm ≈ 1.2 - 2.0 μm ≈ 1.5 - 2.5 μm	AZ [®] 351B, AZ [®] 326 MIF, AZ [®] 726 MIF, AZ [®] Developer	AZ [®] 100 Remover, TechniStrip [®] P1316,	
		AZ [®] 4500	AZ [®] 4533 AZ [®] 4562	≈ 3 - 5 µm ≈ 5 - 10 µm	$AZ^{\$}$ 400K, $AZ^{\$}$ 326 MIF, $AZ^{\$}$ 726 MIF, $AZ^{\$}$ 826 MIF		
		AZ [®] P4000	AZ [®] P4110 AZ [®] P4330 AZ [®] P4620 AZ [®] P4903	≈ 1 - 2 µm ≈ 3 - 5 µm ≈ 6 - 20 µm ≈ 10 - 30 µm	AZ [®] 400K, AZ [®] 326 MIF, AZ [®] 726 MIF, AZ [®] 826 MIF		
	Corrow aporting	AZ [®] 4000	AZ* PL 177	≈ 3 - 8 µm	AZ [®] 351B, AZ [®] 400K, AZ [®] 326 MIF, AZ [®] 726 MIF, AZ [®] 826 MIF	TechniStrip [®] P1331	
	Spray coating	MC Dip Coating	Posist	≈ 1 - 15 µm ~ 2 15 µm	AZ 400K, AZ 320 WIF, AZ 720 WIF, AZ 820 WIF $A7^{(0)}$ 251B $A7^{(0)}$ 400K $A7^{(0)}$ 226 MIE $A7^{(0)}$ 726 MIE $A7^{(0)}$ 926 MIE		
	Steep resist sidewalls, high resolution and aspect ratio for e. g. dry etching or plating	AZ [®] ECI 3000	AZ [®] ECI 3007 AZ [®] ECI 3012 AZ [®] ECI 3027	≈ 0.7 μm ≈ 0.7 μm ≈ 1.0 - 1.5 μm ≈ 2 - 4 μm	AZ [®] 351B, AZ [®] 326 MIF, AZ [®] 726 MIF, AZ [®] Developer	-	
		AZ [®] 9200	AZ [®] 9245 AZ [®] 9260	≈ 3 - 6 µm ≈ 5 - 20 µm	AZ^{\otimes} 400K, AZ^{\otimes} 326 MIF, AZ^{\otimes} 726 MIF		
	Elevated thermal softening point and high resolution for e.g. dry etching	AZ [®] 701 MiR	AZ [®] 701 MiR (14 cPs) AZ [®] 701 MiR (29 cPs)	≈ 0.8 µm ≈ 2 - 3 µm	AZ^{\otimes} 351B, AZ^{\otimes} 326 MIF, AZ^{\otimes} 726 MIF, AZ^{\otimes} Developer		
ositive (chem. nplified)	Steep resist sidewalls, high resolution and aspect ratio for e. g. dry etching or plating	AZ [®] XT	AZ [®] 12 XT-20PL-05 AZ [®] 12 XT-20PL-10 AZ [®] 12 XT-20PL-20 AZ [®] 40 XT	≈ 3 - 5 μm ≈ 6 - 10 μm ≈ 10 - 30 μm ≈ 15 - 50 μm	$AZ^{\$}$ 400K, $AZ^{\$}$ 326 MIF, $AZ^{\$}$ 726 MIF	AZ [®] 100 Remover, TechniStrip [®] P1316, TechniStrip [®] P1331	
ar B		AZ [®] IPS 6050		≈ 20 - 100 µm			
Image Re- versal	Elevated thermal softening point and undercut for lift-off applications	AZ [®] 5200	AZ [®] 5209 AZ [®] 5214 TI 35ESX	≈ 1 µm ≈ 1 - 2 µm ≈ 3 - 4 µm	AZ [®] 351B, AZ [®] 326 MIF, AZ [®] 726 MIF	AZ [®] 100 Remover, TechniStrip [®] P1316,	
		11	TI xLift-X	≈4-8µm		TechniStrip [®] P1331	
e ing)	Negative resist sidewalls in combina- tion with no thermal softening for lift-	AZ [®] nLOF 2000	AZ [®] nLOF 2020 AZ [®] nLOF 2035 AZ [®] nLOF 2070	≈ 1.5 - 3 µm ≈ 3 - 5 µm ≈ 6 - 15 µm	AZ^{\otimes} 326 MIF, AZ^{\otimes} 726 MIF, AZ^{\otimes} 826 MIF		
inki	off application	AZ [®] nLOF 5500	AZ [®] nLOF 5510	≈ 0.7 - 1.5 µm		TechniStrip [®] NI555	
Negat Cross-li	Improved adhesion, steep resist sidewalls and high aspect ratios for e. g. dry etching or plating	A7 [®] nXT	AZ [®] 15 nXT (115 cPs) AZ [®] 15 nXT (450 cPs)	≈ 2 - 3 μm ≈ 5 - 20 μm	$AZ^{\$}$ 326 MIF, $AZ^{\$}$ 726 MIF, $AZ^{\$}$ 826 MIF		
5)			AZ [®] 125 nXT	≈ 20 - 100 µm	AZ^{\otimes} 326 MIF, AZ^{\otimes} 726 MIF, AZ^{\otimes} 826 MIF	TechniStrip [®] P1316, TechniStrip [®] P1331	



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Developers: Application Areas and Compatibilities

Inorganic Developers

(typical demand under standard conditions approx. 20 L developer per L photoresist)

AZ[®] Developer is based on sodium phosphate and -metasilicate, is optimized for minimal aluminum attack and is typically used diluted 1 : 1 in DI water for high contrast or undiluted for high development rates. The dark erosion of this developer is slightly higher compared to other developers.

AZ[®] 351B is based on buffered NaOH and typically used diluted 1 : 4 with water, for thick resists up to 1 : 3 if a lower contrast can be tolerated.

AZ[®] 400K is based on buffered KOH and typically used diluted 1 : 4 with water, for thick resists up to 1 : 3 if a lower contrast can be tolerated.

AZ[®] 303 specifically for the AZ® 111 XFS photoresist based on KOH / NaOH is typically diluted 1 : 3 - 1 : 7 with water, depending on whether a high development rate, or a high contrast is required

Metal Ion Free (TMAH-based) Developers

(typical demand under standard conditions approx. 5 - 10 L developer concentrate per L photoresist)

AZ[®] 326 MIF is 2.38 % TMAH- (TetraMethylAmmoniumHydroxide) in water.

AZ[®] 726 MIF is 2.38 % TMAH- (TetraMethylAmmoniumHydroxide) in water, with additional surfactants for rapid and uniform wetting of the substrate (e. g. for puddle development)

AZ[®] 826 MIF is 2.38 % TMAH- (TetraMethylAmmoniumHydroxide) in water, with additional surfactants for rapid and uniform wetting of the substrate (e. g. for puddle development) and other additives for the removal of poorly soluble resist components (residues with specific resist families), however at the expense of a slightly higher dark erosion.

Removers: Application Areas and Compatibilities

Standard-Remover

AZ[®] 100 Remover is an amine solvent mixture and standard remover for AZ[®] and TI photoresists. To improve its performance, AZ[®] 100 remover can be heated to 60 - 80°C. Because the AZ® 100 Remover reacts highly alkaline with water, it is suitable for this with respect to sensitive substrate materials such as Cu. Al or ITO only if contamination with water can be ruled out.

High Performance Removers of the TechniStrip[®] Series

TechniStrip[®] P1316 is a remover with very strong stripping power for Novolak-based resists (including all AZ[®] positive resists), epoxy-based coatings, polyimides and dry films. At typical application temperatures around 75°C, TechniStrip® P1316 may dissolve cross-linked resists without residue also, e.g. through dry etching or ion implantation. TechniStrip® P1316 can also be used in spraving processes. For alkaline sensitive materials, TechniStrip® P1331 would be an alternative to the P1316. Nicht kompatibel mit Au oder GaAs.

TechniStrip[®] P1331 can be an alternative for TechniStrip[®] P1316 in case of alkaline sensitive materials. TechniStrip[®] P1331 is not compatible with Au or GaAs.

TechniStrip[®] NI555 is a stripper with very strong dissolving power for Novolak-based negative resists such as the AZ[®] 15 nXT and AZ[®] nLOF 2000 series and very thick positive resists such as the AZ[®] 40 XT. TechniStrip[®] NI555 was developed not only to peel cross-linked resists, but also to dissolve them without residues. This prevents contamination of the basin and filter by resist particles and skins, as can occur with standard strippers. TechniStrip® NI555 is not compatible with Au or GaAs.

Further Information

Technical Data Sheets

https://www.microchemicals.com/downloads/product_data_sheets/photoresists.html

Material Safety Data Sheets (MSDS)

https://www.microchemicals.com/downloads/safety data sheets/msds links.html password: yoursheets) (user: microc



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